



Improved Compact Model of Quantum Sub-band Energy Levels for MOSFET Device Application



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Outline

- Triangular potential well approximation.
- WKB approach.
- Self-Consistent Schrödinger-Poisson (SP) numerical approach.
- Compact model with quantum effect.
- Results and comparisons.
- Conclusion.
- Exponential approximation of the potential energy.



Triangular potential well approximation

- 1-D Schrödinger equation

$$\frac{d^2\psi_j}{dx^2} + \frac{2m^*}{\hbar^2}[E_j - U]\psi_j = 0$$

- Where $m^*=0.916m_e$ is electron effective mass in the direction perpendicular to the transistor channel surface, $U(x)=-qF_sx$ and F_s the surface field.



Triangular potential (continued)

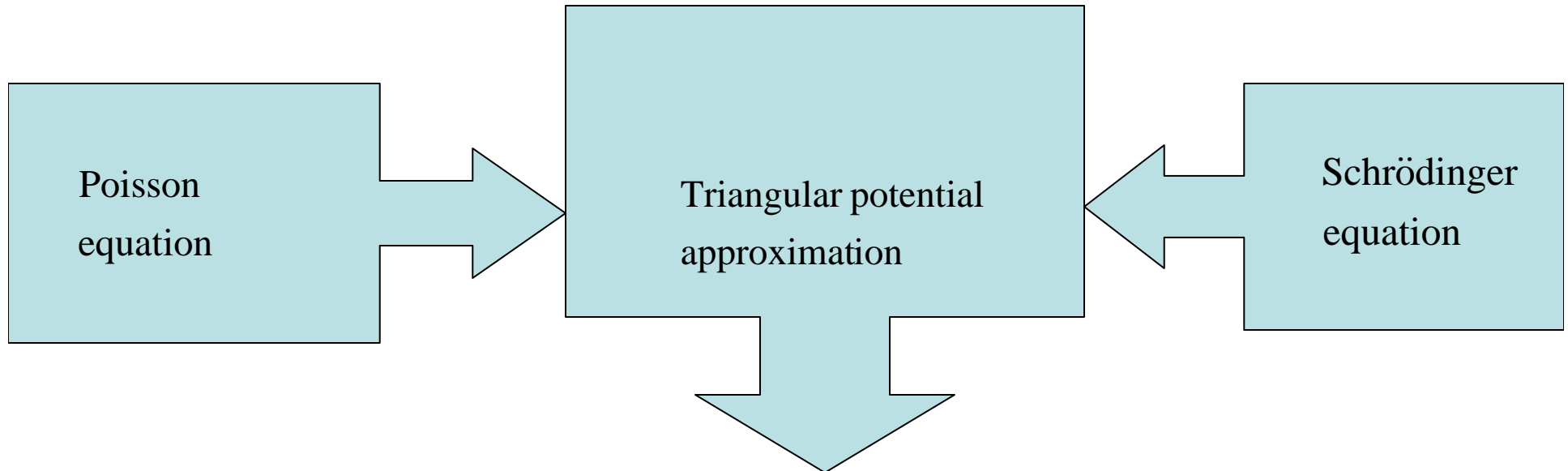
- Solving the eigenvalue problem gives the ***Airy functions*** as solutions for the Schrödinger equation with energy eigenvalues

$$E_j = \left(\frac{\hbar^2}{2m^*} \right)^{1/3} \left((3/2)\pi q F_s \left(j + \frac{3}{4} \right) \right)^{2/3}$$

- Good approximation only for depletion.



Triangular potential (continued)



$$E_j = \left(\frac{\hbar^2}{2m^*} \right)^{1/3} \left((3/2)\pi q F_{seff} \left(j + \frac{3}{4} \right) \right)^{2/3}$$

- Approximation can be improved significantly at strong inversion by using the effective surface field



where $F_{seff} = \eta F_s$

WKB approach

- Improved asymptotic model for the potential:

$$U(x) = -qF_s x$$

Where $F_s = \frac{V_{th} \sqrt{\lambda} (\ln \lambda)^{3/2} f_s}{L_d}$,

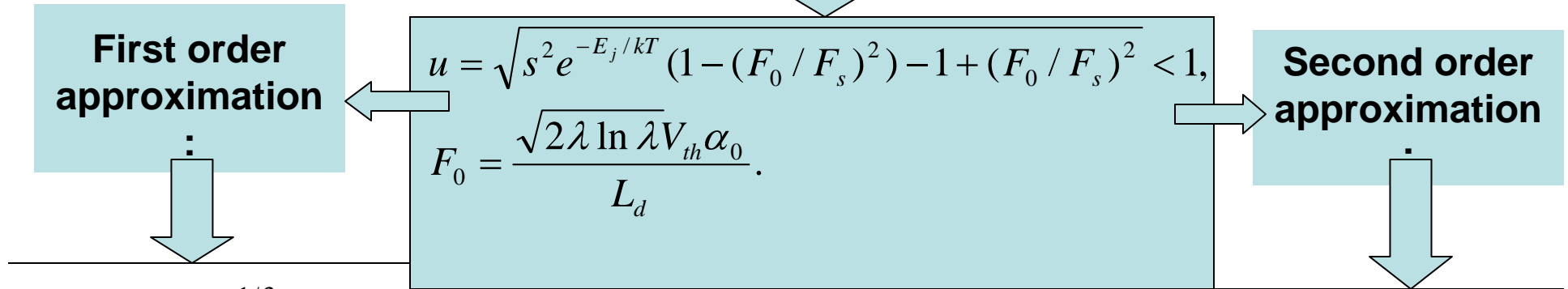
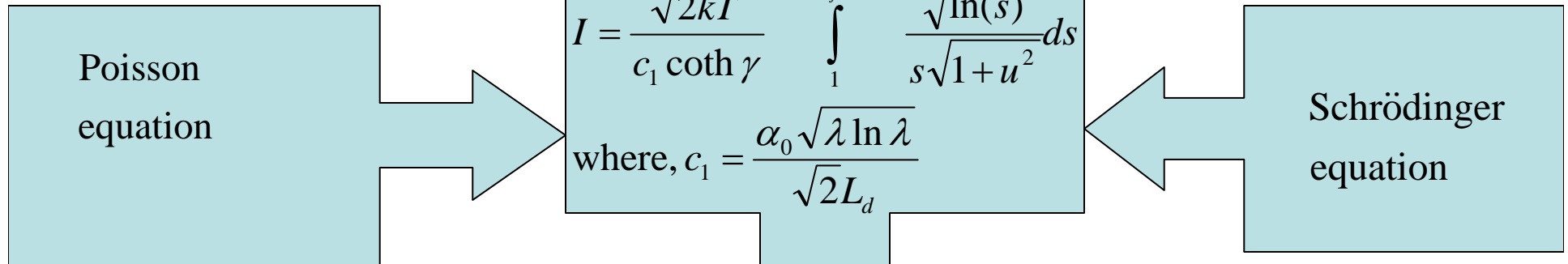
$$f_s = \frac{\sqrt{2} \alpha_0 \coth \gamma}{\ln \lambda}, \quad \gamma = \sinh^{-1}(\alpha), \quad \alpha = \alpha_0 \sqrt{\ln \lambda} \lambda^{(1-w_s+\varphi)/2}$$

$$\alpha_0 = \sqrt{2 + \varphi + \frac{\ln(\ln \lambda)}{\ln \lambda} - \frac{1}{\ln \lambda} + \frac{2}{\ln \lambda} [\ln(2\alpha_0) - \gamma]}, \quad \lambda = N_a / n_i$$

and L_d is the intrinsic Debye length



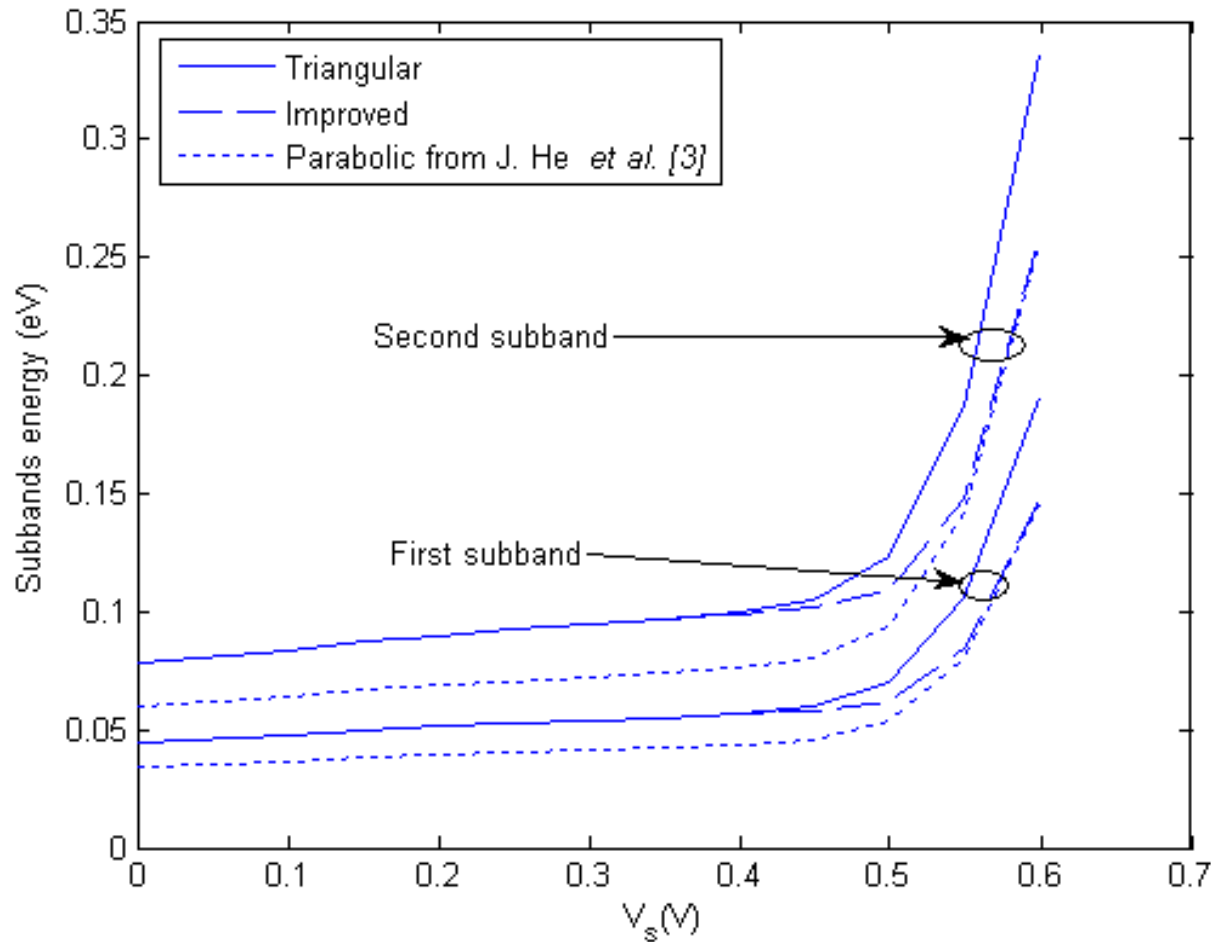
WKB approach



$$E_j = \left(\frac{\hbar^2}{2m^*} \right)^{1/3} \left((3/2)\pi q F_s (j + \frac{3}{4}) \right)^{2/3}$$

$$E_j = \left(\frac{\hbar^2}{2m^*} \right)^{1/3} \left(\frac{(3/2)\pi q F_s (j + \frac{3}{4})}{(3/2) - \frac{(F_0/F_s)^2}{2}} \right)^{2/3}$$





Sub-band energy versus surface potential comparison of different analytical models from[4].

[3] J. He, M. Chan and C. Hu, "A compact model to predict quantized sub-band energy levels and inversion layer centroid of MOSFET with the parabolic potential well approximation," *Proceedings 2005 Nanotechnology Conference, WCM*, pp. 171-174, Anaheim, CA, May 8-12, 2005.

[4] E. Cumberbatch, H. Abebe, and H. Morris, "Current-voltage characteristics from an asymptotic analysis of the MOSFET equations," *J. of Engineering Mathematics*, vol. 39, pp. 25-36, 2001.



WKB approach (continued)

WKB **first order**
integral approximation



Triangular
potential
approximation

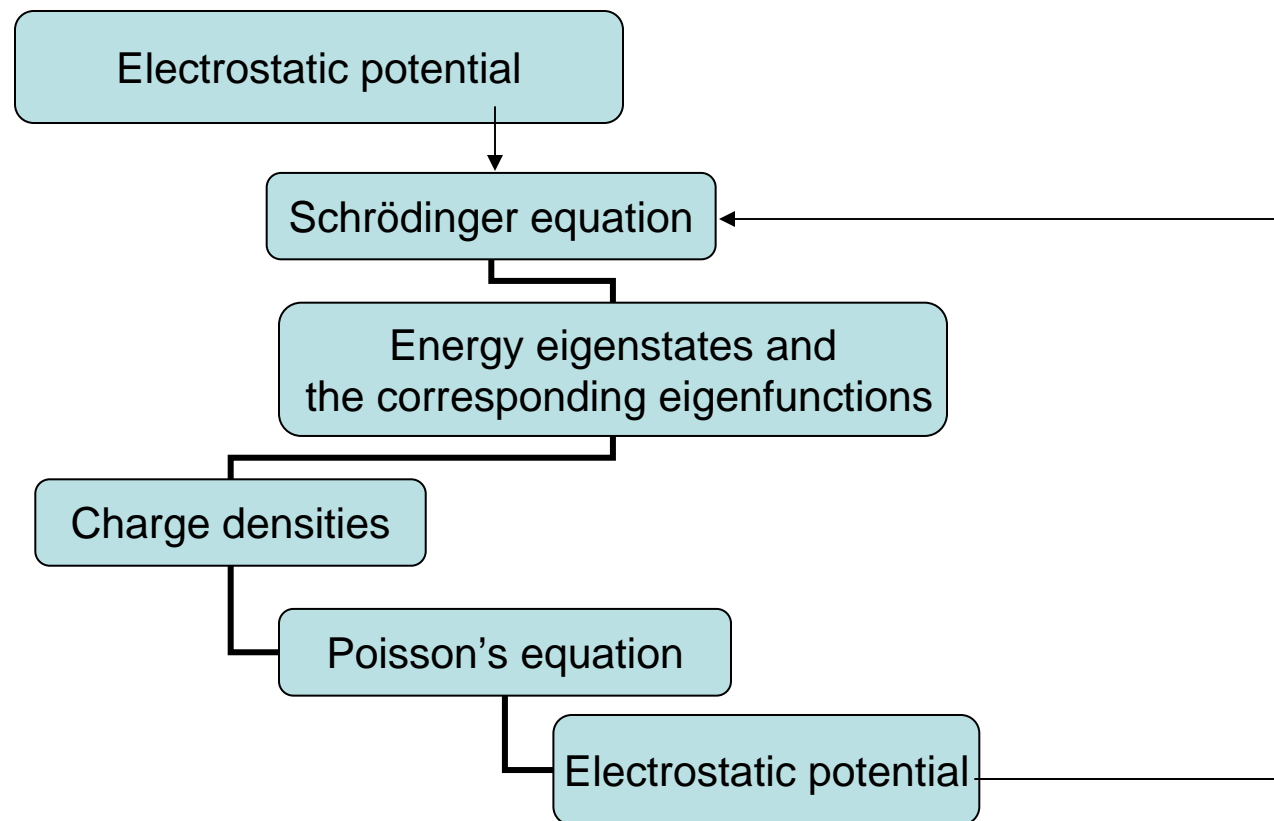
WKB **second order**
integral approximation



parabolic potential
approximation

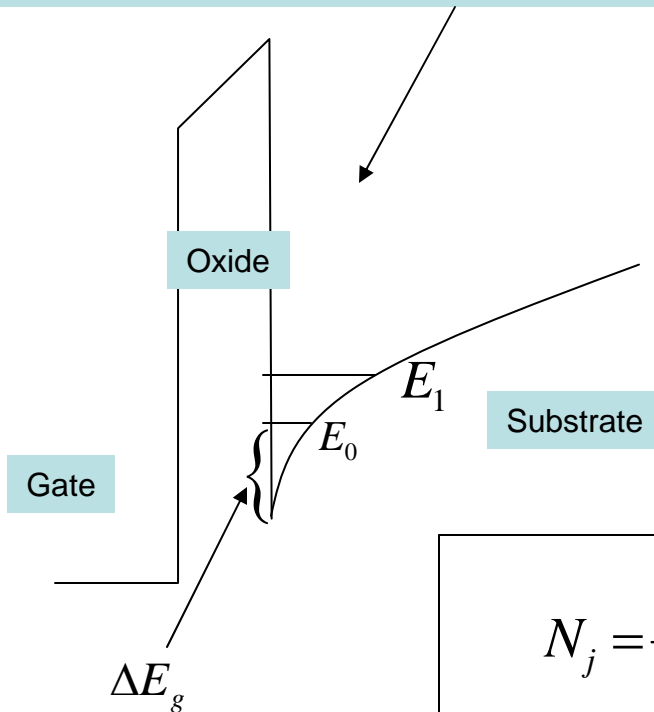


Self-Consistent Schrödinger-Poisson (SP) numerical approach



Compact model with quantum effect

Energy band profile near the interface



The electron concentration in j_{th} sub-band

$$N_j = \frac{0.38m_e}{\pi\hbar^2} \int_{E_j}^{\infty} \frac{dE}{1 + e^{(E-E_f)/kT}} = 0.38m_e \left(\frac{kT}{\pi\hbar^2} \right) \ln(1 + e^{(E_f-E_j)/kT})$$

Carrier concentration: $n(x) = \sum_j N_j \psi_j^2(x)$



Compact model (continues)

- Quantum effect on the intrinsic charge density

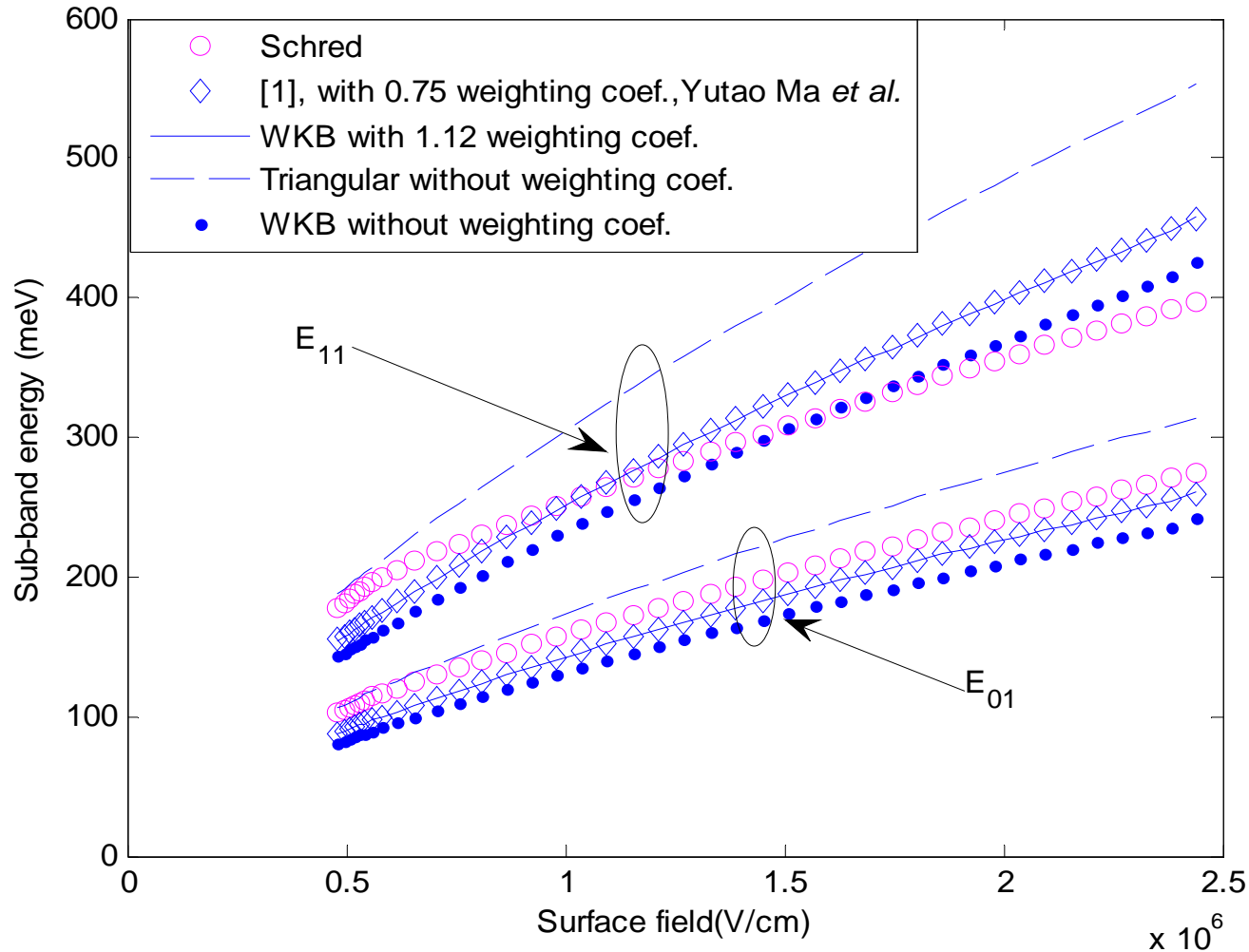
- Classical: →

$$n_i^c = 2 \left(\frac{kT}{2\pi\hbar^2} \right)^{\frac{3}{2}} (m_h m_e)^{\frac{3}{4}} e^{-E_g / 2kT}$$

- Quantum: →

$$n_i^q = e^{-\Delta E_g / 2kT} n_i^c$$

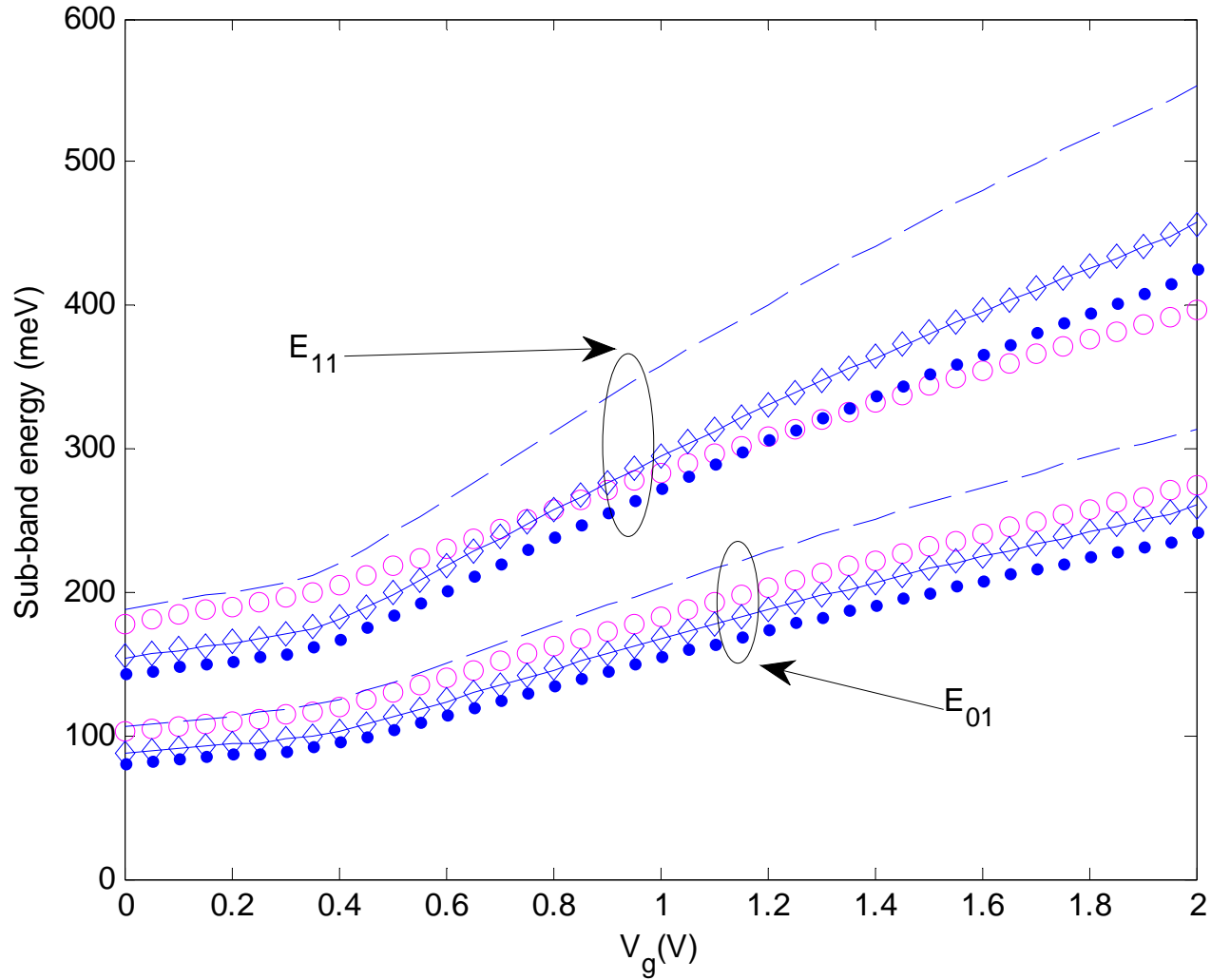




Sub-band energy versus surface field for $N_b=10^{18}\text{cm}^{-3}$ and $t_{ox}=2\text{nm}$.

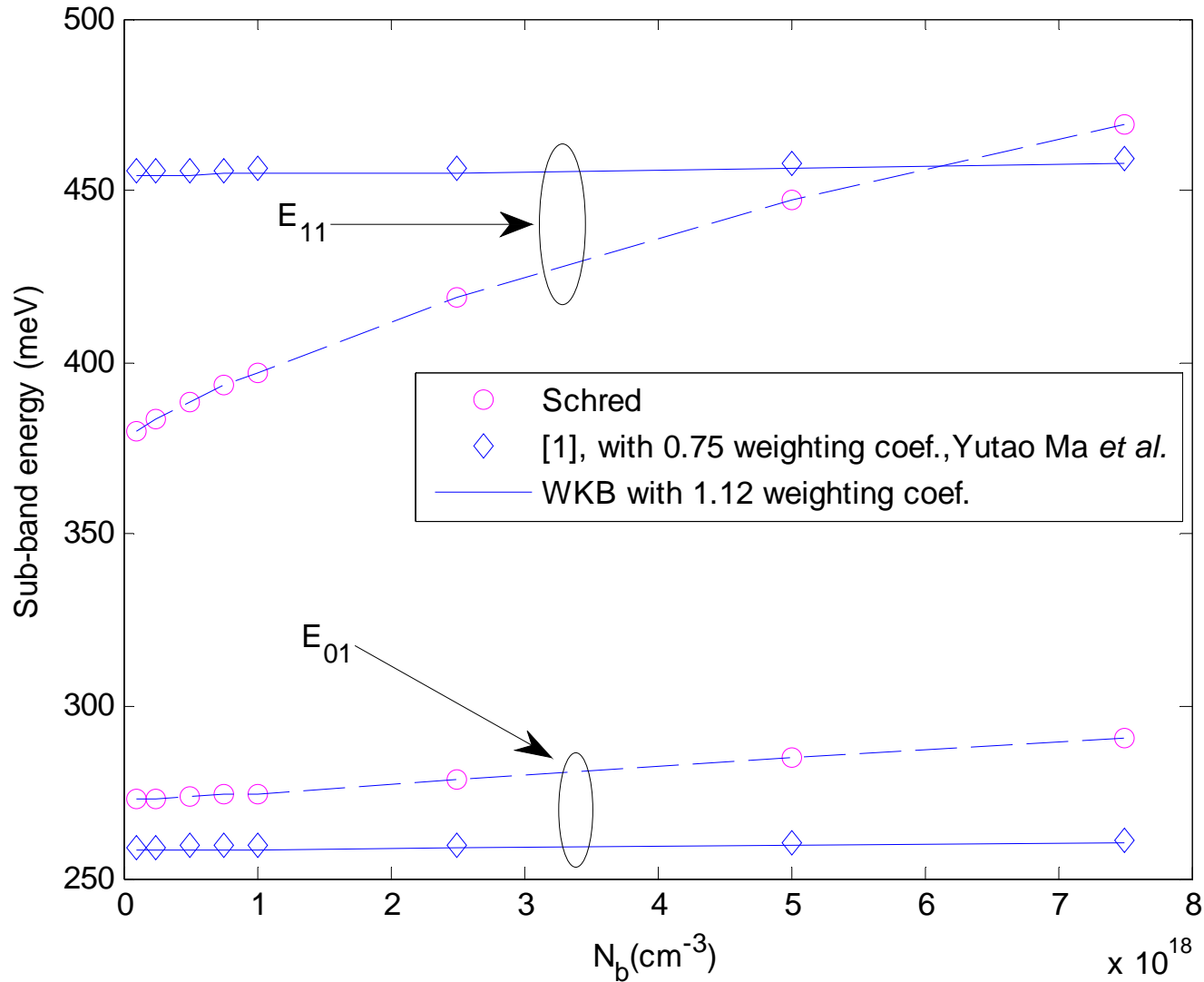
[1] Yutao Ma, Litian Liu, Zhiping Yu, and Zhijian Li, "Validity and applicability of triangular potential well approximation in modeling of MOS structure inversion and accumulation layers," *IEEE Trans. On Electron Devices*, Vol. 47, No. 9, September (2000).





Sub-band energy versus gate voltage for $N_b=10^{18}\text{cm}^{-3}$ and $t_{ox}=2\text{nm}$.





Sub-band energy versus substrate doping for $V_g=2V$ and $t_{ox}=2nm$.



Conclusion

- Triangular potential well and WKB approximation give equivalent sub-band energy results when different weighting coefficients are used in the effective surface field.
- Both Triangular potential well and WKB approximation differ in predicting the substrate doping effect on the first two lower sub-band energy levels compared to the self-consistent 1-D numerical result, SCHRED .
- Effective surface potential correction gives improvement over the original triangular potential well approximation.



Exponential approximation of the potential energy

1-D Schrödinger equation

$$\frac{d^2\zeta}{dx^2} + \frac{2m}{\hbar^2} [E - \alpha(1 - e^{-x/d})] \zeta = 0$$

where $U = \alpha(1 - e^{-x/d})$, $\alpha = \lim_{x \rightarrow \infty} U(x)$, $d = \frac{\alpha}{qF_s}$

$$\tau^2 \frac{d^2\zeta}{d\tau^2} + \tau \frac{d\zeta}{d\tau} + [\tau^2 - (\frac{2d}{\mu} \sqrt{\alpha - E})^2] \zeta = 0$$

where $\tau = \frac{2d}{\mu} \sqrt{\alpha} e^{-x/2d}$, $\mu = \frac{\hbar}{\sqrt{2m}}$



Exponential approximation (continues)

The solution to $\zeta(\tau)$ equation can be written in terms of Bessel functions of the first kind with $\nu = \frac{2d}{\mu} \sqrt{\alpha - E}$:

$$\zeta(x) = C_1 J_\nu \left(\frac{2d}{\mu} \sqrt{\alpha} e^{-x/2d} \right)$$

With boundary conditions: $\zeta(0) = \zeta(\infty) = 0$



Exponential approximation (continues)

Boundary condition at $x=0$ \longrightarrow eigen value equation

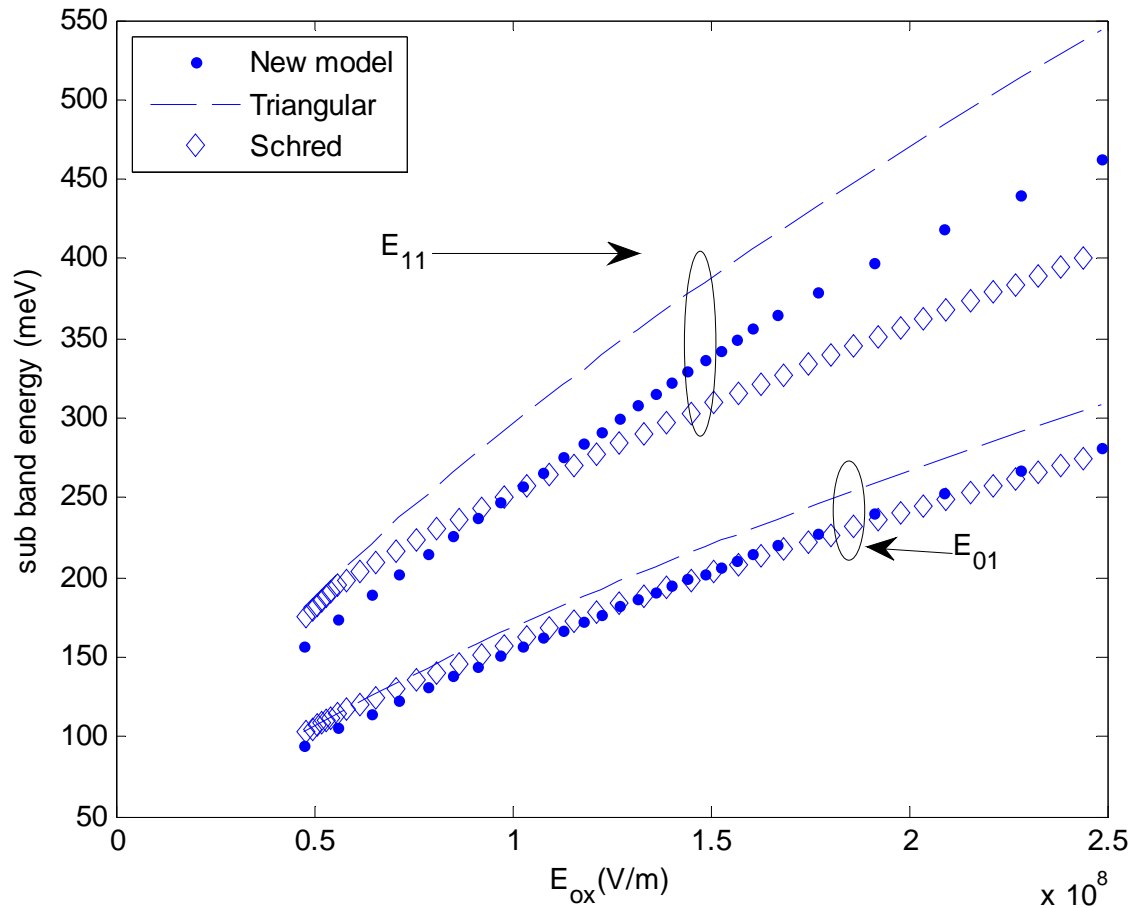
$$\zeta(0) = J_\nu(\nu \sec \beta) = 0 \quad \text{where} \quad \beta = \sec^{-1} \left(\sqrt{\frac{\alpha}{\alpha - E}} \right)$$

For $\nu \gg \gg 1$ we have asymptotic expansion ($\nu \sim 100$):

$$J_\nu(\nu \sec \beta) \sim \frac{\cos\left[\nu(\tan \beta - \beta) - \frac{1}{4}\pi\right]}{\sqrt{\frac{1}{2}\nu\pi \tan \beta}} = 0$$

$$E_j = \alpha \sin^2 \beta_j$$





Energy band level for triangular and exponential approximations compared with numerical results from SCHRED at various surface field for $N_b=10^{18}cm^{-3}$ and $t_{ox}=2nm$. The first two energy levels are shown.

